## Application/Control No. Applicant(s)/Patent Under Reexamination 10/575,464 TANAKA ET AL. Notice of References Cited Examiner **Art Unit** Page 1 of 1 Zeev Kitov 2836 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,416,665 05-1995 Nishiwaki et al. Α 361/154 US-5,202,813 04-1993 Uota et al. В 361/154 С US-6,169,431 01-2001 Xu, Chihao 327/109 US-D US-E US-F US-G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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